

<b>Issue Classification</b>			Application/Control No.		Applicant(s)/Patent under Reexamination	
			10/600,502		LEVIN ET AL.	
			Examiner		Art Unit	
			Eva Yi Zheng		2611	

<b>ISSUE CLASSIFICATION</b>							
ORIGINAL		CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375	265	375	341	261	262	324	332
INTERNATIONAL CLASSIFICATION		714	792	795	796		
H	0	4	L	23/02			
				/			
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<i>Eva Zheng 8/14/07</i> (Assistant Examiner) (Date)				<i>Chieh M. Fan</i> CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) <i>A716107</i>			
				Total Claims Allowed: 14 O.G. Print Claim(s) 16 O.G. Print Fig. 9			

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5		35		65	95	125	155
6		36		66	96	126	156
7		37		67	97	127	157
8		38		68	98	128	158
9		39		69	99	129	159
10		40		70	100	130	160
11		41		71	101	131	161
12		42		72	102	132	162
13		43		73	103	133	163
14		44		74	104	134	164
15		45		75	105	135	165
16		46		76	106	136	166
17		47		77	107	137	167
18		48		78	108	138	168
19		49		79	109	139	169
20		50		80	110	140	170
21		51		81	111	141	171
22		52		82	112	142	172
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24		54		84	114	144	174
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26		56		86	116	146	176
27		57		87	117	147	177
28		58		88	118	148	178
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